

Notice of References Cited

Application/Control No.

09/492,146

Applicant(s)/Patent Under
Reexamination
MISAWA, TAKESHI

Examiner

John M. Villecco

Art Unit

2612

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0043276 ✓	11-2001	UENO, HIROYUKI	348/322
	B	US-6,529,236 ✓	03-2003	Watanabe, Mikio	348/230.1
	C	US-6,130,420 ✓	10-2000	Tanaka et al.	250/208.1
	D	US-6,075,565 ✓	06-2000	Tanaka et al.	348/312
	E	US-6,236,434 ✓	05-2001	Yamada, Tetsuo	348/315
	F	US-6,496,224 ✓	12-2002	Ueno, Hiroyuki	348/322
	G	US-6,583,818 ✓	06-2003	Toma, Tetsuo	348/312
	H	US-6,423,959 ✓	07-2002	Ikeda et al.	250/208.1
	I	US-6,426,493 ✓	07-2002	Oda, Kazuya	250/208.1
	J	US-2002/0171033	11-2002	Okada, Yoshihiro	250/208.1
	K	US-4,242,700	12-1980	Weimer, Paul K.	348/275
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.